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| REPORT DOCUMENTATION PAGE | | | | Form Approved | | | | |
|--|--|---|--|---|---|---|--|---------------------|
| 1a. REPORT SECURITY CLASSIFICATION | | | 1b. RESTRICTIVE | MARKINGS | | | | |
| Unclassified - TR 453 20. SECURITY CLASSIFICATION AUTHORITY | | | | | | | | |
| 26. DECLASSIFICATION / DOWNGRADING SCHEDULE | | | Approved for public release; distribution is unlimited. | | | | | |
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ACKNOWLEDGEMENTS

The U.S. Army Materiel Systems Analysis Activity (AMSAA) recognizes the following individual for contributing to this report.

Peer Reviewer: James J. Streilein

The authors wish to recognize the following for his contribution to Appendix A.

Robert Mioduski, Reliability, Availability, and Maintainability Division (RAMD)



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STATISTICAL PRECISION AND ROBUSTNESS OF THE AMSAA CONTINUOUS RELIABILITY GROWTH ESTIMATORS

1. INTRODUCTION

1.1 Discussion of Reliability Growth.

The U.S. Army Materiel Systems Analysis Activity (AMSAA) employs the Weibull process to model reliability growth during a development test phase. Development test programs are generally conducted on a phase by phase basis. The AMSAA reliability growth model is designed for tracking the reliability within a test phase. This model evaluates the reliability growth that results from the introduction of design fixes into the system during test.

Figure 1 illustrates a typical pattern of growth on a phase by phase basis.





The AMSAA tracking model addresses the reliability growth within a particular test phase. Several tracking growth curves may be required to measure reliability growth over multiple test phases due to the incorporation of groups of fixes between test phases and/or changes in test phase environments.

Assume the test phase starts at time t = o. Within the test phase, let $o < t_1 < t_2 < \ldots < t_k$ denote the cumulative test times on the system when design modifications are made (see Figure 2).



Figure 2. Times of Design Modifications for Test Phase 2.

The failure rate can generally be assumed to be constant between the times when design changes are made on the system. Let λ_i denote the constant failure rate during the ith time period $[t_{i-1}, t_i]$ between modifications (see Figure 3).



Figure 3. Failure Rates Between Modifications.

The constant failure rate assumption during $[t_{j-1}, t_j]$ implies that for this interval, the times between successive failures follow the exponential distribution $F(x) = 1 - \exp(-\lambda_1 x)$, x>0.

The AMSAA tracking model approximates the step-wise failure rate function shown in Figure 3 by a smooth curve. The parameters of this curve are estimated, based upon the failure data observed during the test phase.

1.2 Objectives of Our Study.

The objectives of our study are to:

a. Study the statistical precision of the AMSAA MIL-HDBK-189 (Reference 1) mean time between failure (MTBF) estimators M-HAT and M-BAR.

b. Study robustness, i.e., the effect on estimator statistical precision due to discrete configuration changes (i.e., the step-wise discontinuous faibure rate curve).

2. ESTIMATION PROCEDURES ANALYZED

In the subsequent sections, we shall define several important statistical properties of reliability estimators. We shall then study these properties for the MIL-HDBK-189 reliability growth estimation procedures applied to time-terminated testing.

The data used for the analysis consists of the N successive failure times $f_1 < f_2 < f_3 < \ldots < f_N$ which occur during a test phase of duration T. The method of maximum likelihood utilized in the MIL-HDBK-189 estimation procedure provides the estimate of the shape parameter β as

$$\hat{\beta} = \frac{N}{N \ln T - \sum_{i=1}^{N} \ln f_i}$$

where ²n denotes the natural logarithm function.

Subsequently, the scale parameter λ is estimated by $\hat{\lambda} = N/T\hat{\beta}$. It follows that for any time t, the intensity function (failure rate) is estimated by $\hat{P}(t) = \hat{\lambda}\hat{\beta} t^{\beta-1}$. In particular, this holds for T, the total test time. The reciprocal of $\hat{P}(T)$ provides an estimate of the MTBF which could be anticipated if the system configuration remains as it is at time T. This estimate is denoted by \hat{M} . Thus $\hat{M} = 1/\hat{P}(T) = T/N\hat{\beta}$. For small sample sizes, it is appropriate to use an unbiased estimator β of the shape parameter β . The estimator $\overline{\beta}$ is defined in MIL-HDBK-189 as

$$\overline{B} = \left(\frac{N-1}{N}\right) \hat{\beta}, N \ge 2.$$

In our study, we defined the estimator \overline{B} as follows:

$$\overline{B} = \begin{pmatrix} \widehat{B} \text{ for } N = 1 \\ \begin{pmatrix} N-1 \\ N \end{pmatrix} \quad \widehat{B} \text{ for } N \ge 2 \end{pmatrix}$$

Notice the estimator β defined above is unbiased only for N ≥ 2 .

The estimator \overline{M} of MTBF can be calculated by using the unbiased estimator \overline{B} as follows:

 $\overline{M} = T/N\overline{B}$ for N > 1

3. PRECISION

<u>Definition</u>: Precision of an estimator is measured by the Relative Error, RE, defined by

RE = |M(EST) - M(TRUE)|/M(TRUE)

where $M_{(EST)} = \hat{M}$, calculated from the maximum likelihood estimator $\hat{\beta}$ of the shape parameter β or $M_{(EST)} = \overline{M}$, calculated from the unbiased estimator $\overline{\beta}$ of the shape parameter β . (EST) the above, $M_{(TRUE)}$ denotes the MTBF at the end of the test time.

Since $M_{(EST)}$ is a random variable, RE is a random variable and so we can consider its distribution. This distribution can be simulated by using data generated from the AMSAA continuous failure-rate curve.

It has been found that the probability of achieving a specified precision (i.e., specified relative error) depends solely upon the expected number of failures (see Appendix A). In fact, an analytical expression in terms of the expected number of failures can be found for the distribution function of the relative error. However, for our purposes, we found it more convenient and adequate to use simulation to estimate the probability that the relative error would be less than or equal to a specified value.

In our study we simulated 5,000 failure histories for estimating the probability of achieving a specified precision with M and M. The estimated probabilities were conditioned on the set of failure histories that had at least one failure. For each simulation run, the number of failures N and cumulative failure times $f_1, f_2, f_3, \ldots, f_N$ were recorded. The total test time T was chosen to be 1,000 hours, 5,000 hours, and 10,000 hours. For each test length, the MTBF estimators, M and M, were calculated and, thereby, the distribution of relative error was obtained to analyze the behaviour of the MTBF estimators. It was found that M and M behave in the same way, especially when the expected number of failures is moderate to large (see Figures 4 and 5).

4. ROBUSTNESS

<u>Definition</u>: Robustness is defined to be the ability of an estimator to perform well even when the underlying assumptions are violated.

For the purpose of our study, we considered a class of step functions which were compatible with the AMSAA tracking model and whose discreteness could be simply characterized (see Appendix C). In the step function construction, the steps represent the constant failure rates over different configurations. By simulation the failure data were generated from the step function failure







rate curves, and then MIL-HDBK-189 estimators \widetilde{M} and \overline{M} were computed as in Section 2. For both estimators, the distributions of RE were computed. As defined in a previous section, the RE is:

$$RE = |M(EST) - M(TRUE)|/M(TRUE)$$

For the step function construction, $M_{(TRUE)}$ is the MTBF of the system's last configuration. From the simulation results for the discrete failure rate curve, it was observed that the probability of achieving a specified precision strongly depends upon the expected number of failures and weakly upon the number of configurations for about five or more configurations (see Figures 6 and 7). Notice that the \overline{M} estimator behaves in the same way. It is important to note that the probability of achieving a specified precision for a finite number of configurations rapidly approaches the probability obtained for the smooth AMSAA failure rate curve, as the number of configurations increases.

5. APPLICATIONS

The following computational examples will show how to use the relationship between the probability of achieving a specified precision and the expected number of failures to analyze an idealized planning curve.

Computational Examples.

a. Determine the amount of test time to achieve a specified precision with a given probability.

As an example of this type of problem, we shall calculate the amount of test time required to ensure with a probability of 0.80 that the MTBF estimator \widehat{M} will be within 20 percent of the true (unknown) MTBF, M(TRUF).

Typically, one attempts to develop an idealized growth curve that will grow to a desired value, MF. This value, MF, may be the required MTBF, or it may be a value higher than the required MTBF. The latter case will occur when one is required to demonstrate the desired system's MTBF at a specified confidence level. In either event, we will assume in this example that the end point of the planning curve has been determined and denoted by MF. Assume we actually grow along the idealized curve to the end point after T hours. Then M(TRUE) will equal MF. In this example, we wish to calculate a value for T that will ensure with a probability of 0.80 that |M - M(TRUE)| < (0.20) M(TRUE). This value of T depends on the expected number of failures associated with the idealized growth curve. The expected number of failures required to ensure a specified relative error with a probability of 0.80 can be found from a family of "Relative Error vs Expected Number of Failures" curves (see Appendix B).

It can be shown that the expected number of failures, E(F), may be expressed with

 $E(F) = (1/(1-\alpha)) (T/M_F)$







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Figure 7. Probability of 20% Precision vs. Number of Configurations for M

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Thus for an assumed growth rate, for example, $\alpha = 0.2$, specified precision = 0.2 and M_F = 168 hours, we see from Figure 9, Appendix B, that E(F) = 93 and T may be calculated as follows:

- $T = (1 \alpha) (M_F) (E(F))$
 - = (1 0.2) (168) (93)
 - = 12499.2 hours

Notice that for a given M_F and E(F), there is a linear relationship between the test time, T, and the growth rate, α . The idealized growth curve that corresponds to the specified growth rate of 0.2 and that grows to the desired MTBF, $M_F = 168$ hours in an amount of time, T = 12499.2 hours can be completely specified by using the following relationship:

 $E(F) = \lambda T^{\beta}$ where $\beta = 1 - \alpha$

Solving for λ , we obtain,

 $\lambda = (E(F))T^{-\beta}$

The equation of the idealized growth curve is now completely specified.

b. For a given amount of test time T and MTBF value MF to be achieved at the end of test time T, what precision (i.e., relative error) of the M estimator can be ensured with a specified probability for a stated growth rate.

In our example, the given amount of test time will be T = 3542 hours and MF will be taken to be 197 hours. We wish to calculate the precision of the M estimator that can be achieved with a probability of 0.80 for a growth curve with growth rate $\alpha = 0.3$.

The expected number of failures, E(F), can be calculated to be 26 by using one of the following formulas.

$$E(F) = (1/(1-\alpha)) (T/M_F)$$

or
$$E(F) = \lambda T^{\beta} = \lambda T (1 - \alpha)$$

From Figure 9, Appendix B, we see that PROB (RE < 0.36) = 0.80.

6. CONCLUSIONS

From Section 3 regarding precision, we conclude the following:

a. The probability of achieving a specified precision increases as the expected number of failures increase.

b. The precision of \widehat{M} and \overline{M} is essentially the same.

c. It is important to choose idealized planning curve parameters (T, α, λ) to obtain adequate precision (i.e., RES) for the estimator at the desired probability level. In particular, we should state the specified precision (i.e., specified relative error), RES, and probability level, PR, where

$$PROB \left(\begin{array}{c} |M(EST) - M(TRUE)| \\ ----- < RE_{S} \end{array} \right) = PR$$

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d. For a given idealized planning curve and test time, one can calculate the risk that the estimate will not be within a specified percent of the true MTBF, e.g., for the specified percent = 20 percent

Risk = PROB (|M(EST) - M(TRUE)| > 0.20 M(TRUE))

e. This study emphasizes the need to include the confidence bounds on the true MTBF when presenting evaluations based on the MIL-HDBK-189 MTBF estimators. It could be misleading to only present point estimates in cases where the probability of obtaining good precision is low.

From Section 4 regarding robustness, we conclude that:

a. The precision of MIL-HDBK-189 estimators strongly depends on the expected number of failures.

b. The robustness of \widehat{M} and \overline{M} is essentially the same.

c. For a small expected number of failures, although the probability of achieving a specified precision is low, it is robust with respect to the number of configurations.

d. For a high expected number of failures, the probability is not robust for a small number of configurations. This emphasizes the need for instituting Test, Analyze, and Fix (TAAF) procedures for long duration growth programs when the expected number of failures is high.

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APPENDIX A

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DISTRIBUTION OF RELATIVE ERROR

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APPENDIX A

DISTRIBUTION OF RELATIVE ERROR

In this appendix, we shall obtain the distribution function of the relative error, RE, where RE is defined as in Section 3. It will be seen that the distribution function is governed by only one scalar parameter, the expected number of failures for the reliability growth test.

For a time terminated growth test of duration T, the AMSAA continuous model assumes the failure process {N_t|0<t<T} is a nonhomogeneous Poisson process with intensity function $\rho(t) = \lambda_{B}t^{B-I}$ (λ >0, β >0). The variate N_t denotes the cumulative number of failures through test time t. The expected value of N_t, denoted by E(N_t), is given by

$$E(N_t) = \int_0^t \rho(s) ds = \lambda t^{\beta}$$
(1)

for t>0.

Let $W = \sum_{i=1}^{N_t} \ln(T/f_i)$

where f_i denotes the cumulative test time to the ith failure. The sum is defined to be zero when $N_t=0$. In Reference 2, the distribution of W conditioned on $N_T=n>1$ is derived. This distribution can be used to obtain the distribution of RE.

Let n>1 and let W_n denote W conditioned on $N_T=n$. Define f_W to be the density function of W_n . In Reference 2, it is shown that

 $f_{W_n}(W) = \frac{(\beta W)^{n-1}e^{-\beta W} \beta}{(n-1)!}$ for W>0 = 0 for W<0.

To further consider the distribution of W_n , let G(r,s) denote a gamma random variable with density function

$$g(x) = \frac{1}{s^{r}r(r)} x^{r-1}e^{-x/s} \text{ for } x>0$$

= 0 for x<0

where r>0 and s>0.

Thus, $W_n \sim G(n, \beta^{-1})$. We may also express W_n in terms of a Chi-Square variate with 2r degrees of freedom, denoted by χ_{2r}^2 . To do so, we note

$$G(r,s) = (s/2) \chi_{2r}^2$$

(2)

Thus by (2), with r=n and $s=\beta^{-1}$,

$$W_n \sim (1/2\beta) \chi_{2n}^2$$
 (3)

Recall that the maximum likelihood estimate (MLE) for β is given by

$$\hat{\beta} = N_T / \sum_{i=1}^{N_T} \ln(T/f_i)$$
(4)

Let $\hat{\beta}_n$ and \hat{M}_n denote the variates $\hat{\beta}$ and MTBF MLE \hat{M} conditioned on $N_T = n \ge 1$, respectively. Then by (4),

$$\hat{\beta}_n = \frac{n}{W_n}$$
(5)

Recall $\hat{M} = T/\hat{\beta}N_T$ and thus

Then, by (5).

$$\widehat{M}_{n} = T/\widehat{\beta}_{n}n \tag{6}$$

Let $M = 1/\rho(T)$, the instantaneous MTBF at the end of the growth program.

$$\hat{\mathbf{M}}_{n}/\mathbf{M} = (\lambda T^{\beta}/n) (\beta/\hat{\beta}_{n})$$

$$= (\lambda T^{\beta}/n) \left(\frac{\beta W_{n}}{n}\right)$$

$$= \left(\frac{\lambda T^{\beta}}{2n^{2}}\right) (2\beta W_{n})$$
(7)

Using (7) and (3) we obtain

$$\hat{M}_{n}/M = \left(\frac{\lambda T^{\beta}}{2n^{2}}\right) \chi_{2n}^{2}$$
(8)

Next, observe that $N_{\ensuremath{\mathsf{T}}}$ is a Poisson random variable.

By (1),
$$E(N_T) = \lambda T^{\beta}$$
. Thus,
 $Pr(N_T = k) = e^{-\lambda T^{\beta}} \frac{(\lambda T^{\beta})^k}{k!}$
(9)

for k = 0, 1, 2, ...

where Pr denotes the Poisson probability function. Also note

$$RE = \left| \frac{\widehat{M} - M}{M} \right| = \left| \frac{\widehat{M}}{M} - 1 \right|$$
(10)

where \widehat{M} denotes the MLE for MTBF defined for n>1. Thus, the distribution of RE is determined by that of \widehat{M}/M .

Let F denote the distribution function of \widehat{M}/M and let F_n denote the distribution function of \widehat{M}_n/M for n>1. Then,

$$F(x) = \sum_{n=1}^{\infty} F_n(x) \frac{Pr(N_T=n)}{\{1 - Pr(N_T=0)\}} \text{ for } x>0$$
(11)

and

F(x) = 0 for x < 0.

By equations (8) and (9), we have that $F_n(x)$ and its coefficient in (11) are solely functions of $\lambda T^{\beta} = E(N_T)$ for each positive integer n. Thus by (10), it follows that the distribution of RE is determined by the parameter $E(N_T)$. Furthermore, the distribution function of RE may be evaluated for a given value of λT^{β} via formulas (10), (11), (8), and (9).

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APPENDIX B

SPECIFIED RELATIVE ERROR VS EXPECTED NUMBER OF FAILURES

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APPENDIX B SPECIFIED RELATIVE ERROR VS EXPECTED NUMBER OF FAILURES

To generate the "Specified Relative Error vs Expected Number of Failures" graph, we used the family of "Probability of achieving REs vs REs" curves (see Figure 8) in which the expected number of failures is constant for a particular curve. These curves depict the variation in the probability of achieving the system's true MTBF within a specified precision for the given expected number of failures.

Most often, we are interested in finding the total test time for a specified precision, say 0.20, and a given probability, say 0.80. Though it is possible to accomplish this objective by directly using the family of curves in Figure 8, it is more convenient to use the graph in Figure 9. To construct this graph, we draw a horizontal line in Figure 8 at a point corresponding to the given probability, say 0.80. From the points of intersection between the line and the curves, draw perpendiculars to the horizontal axis representing the specified relative error (RES), see Figure 10. Record the specified relative errors corresponding to the points of intersection between the perpendiculars and the horizontal axis. We know that the expected number of failures remains constant along a particular curve and it varies for different curves. In this way, we can collect data representing the values for the expected number of failures and the corresponding is used to construct the desired curve, i.e., Figure 9.



Figure 8. Probability of Achieving RE_S vs RE_S.





APPENDIX C

CONSTRUCTION OF STEP FUNCTION FAILURE RATE CURVES

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APPENDIX C CONSTRUCTION OF STEP FUNCTION FAILURE RATE CURVES

The total test time T is divided into s equal size sub-intervals. For each sub-interval i (i=1,...,s), the constant failure - rate ρ_i is defined as the average value of $p(t) = \lambda \beta t^{\beta-1}$ over sub-interval i. This construction is represented graphically for s = 4 in Figure 11. ρ1 ۶ م FAILURE RATE P3 P4 $\rho(\dagger) = \lambda \beta \dagger \frac{\beta - 1}{2}$ tī †2 <u>†3</u> = 14 0 Į HEIGHT OF iTH RECTANGLE (i=1,2,3,4) $\rho_i =$ $t_i = i (T/s) = i(T/4)$ • .

Figure 11. Step Function Failure Rate Curve.

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REFERENCES

1. MIL-HDBK-189, "Reliability Growth Management," 13 February 1981.

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2. Crow, Larry H., AMSAA TR-197, "Confidence Interval Procedures for Reliability Growth Analysis," June 1977.

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Statistical Precision and Robustness of the AMSAA Continuous Reliability Growth Estimators BRIEFING _____ REPORT TR 453



THE PRINCIPAL FINDINGS

1. The probability of achieving a specified precision solely depends upon the expected number of failures when the failure data are generated from the AMSAA Continuous failure rate curve.

2. The probability of achieving a specified precision still strongly depends upon the expected number of failures when failure data come from a finite number of configurations.

3. Precision and Robustness of MTBF estimators \widehat{M} and \overline{M} are essentially the same.

THE MAIN ASSUMPTIONS

1. For the precision part of the study, the failure data are assumed to be generated from the AMSAA continuous failure rate curve.

2. For the robustness part of the study, the failure data are assumed to be generated from a finite number of configurations whose overall trend follows the AMSAA failure rate curve.

3. We studied robustness with respect to the number of configurations by choosing equal configuration time periods.

THE PRINCIPAL LIMITATIONS We used (MIL-HDBK-189) MTBF estimators' formulas under the assumption that failure data are coming from the AMSAA continuous failure rate curve for the precision part. We used the same formulas to study robustness with the assumption that failure data are coming from a finite number of equal configuration time periods.

THE SCOPE OF THE STUDY

This methodology can be used to calculate the required test time associated with an idealized planning curve to achieve a specified precision with a given probability.

THE STUDY OBJECTIVE

1. To study the statistical precision of the AMSAA (MIL-HDBK-189) MTBF estimators M and \overline{M} .

2. To study robustness, i.e., the effect on the estimator statistical precision due to the discrete configuration changes.

AMSAA Form 43R (3 Apr 87) Previous editions of this form are obsolete

THE BASIC APPROACH

1. To determine the precision of the MIL-HDBK-189 MTBF estimators, we did 5000 simulations to generate a distribution of relative error of the MTBF estimators. The failure data were generated from the AMSAA continuous failure rate curve.

2. To determine the robustness, we generated a distribution of relative error from a finite number of configurations through 5000 simulations.

REASON FOR PERFORMING THE STUDY

The study results are useful for planning purposes. We can determine the test

time for a probability and a specified precision level.

IMPACT

Reliability growth plan.

STUDY SPONSOR

U.S. Army Materiel Systems Analysis Activity (USAMSAA), RAM Division

PRINCIPAL INVESTIGATORS

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